

Search Notes

Application/Control No.

09/908,970

Examiner

Cheukfan Lee

Applicant(s)/Patent under Reexamination

SEKIYA ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
358	465,466	8/9/2005	C.L.
	498,488		
	475,496		
	444,404		
	474,401		
399	367		
	371		
	370		
	376		
	9,10		
	11,16,17		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: terms include: (EEPROM (nonvolatile (non adj volatile))) same (volatile memory RAM) same	8/9/2005	C.L.
search terms (cont.): (greater larger exceed\$3 higher bigger smaller less\$2 lower)		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
358	404,444	8/17/2005	C.L.
	465,475		
	488,498		